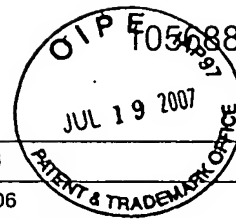




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	Filing Date	2006-09-06
	First Named Inventor	Jose Carlos Ortiz Aleman
	Art Unit	
	Examiner Name	
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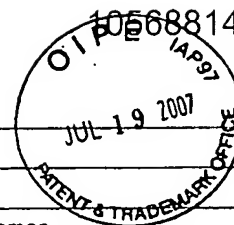
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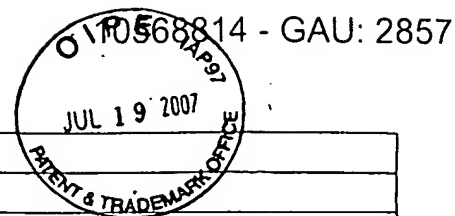
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/DM/	12	METROPOLIS N., Equation of state calculations by fast computing machines, J. Chem. Phys., 1953, Vol. 21, No. 6, pp. 1087-1092.	<input type="checkbox"/>
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/DM/	23	VASUDEVAN K., Simulated annealing static computation using an order-based energy function, Geophysics, 1991, Vol. 56, pp. 1831-1839.	<input type="checkbox"/>
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/DM/		BECK et al., Principles and Industrial Applications of Electrical Capacitance Tomography, Measurement + Control, Vol. 30, Sept. 1997, pp. 197-200.
/DM/		XIE et al., Electrical Capacitance Tomography for Flow Imaging: System Model for Development of Image Reconstruction Algorithms and Design of Primary Sensors, IEE Proc.-G, Vol. 139, No. 1, Feb. 1992, pp. 89-98.

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